

**AUDIX CORPORATION****TECHNICAL DIVISION EMC DEPARTMENT**

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Technical Compliance Statement

No. EM-E930254

The following products has been tested by us with the listed standards and found in compliance with the council EMC directive 89/336/EEC. It is possible to use CE marking to demonstrate the compliance with this EMC Directive.

Submittor : FSP Group Inc.**No. 22, Jianguo E. Rd., Taoyuan City, Taiwan, R.O.C.****Product : Switching Power Supply**

**M/N (1)ATX-300PNF (2)ATX-350PNF (3)ATX-400PNF
 (4)Z350-12APNF (5)Z400-12APNF (6)Z450-12APNF
 (7)xX350-PNF (8)xX400-PNF (9)xX450-PNF
 (Item 7-9 first x = A ~ Z)**

Test Standards	
EN 61204-3/2000	Low voltage power supplies, d.c. output Part 3: Electromagnetic compatibility (EMC)
EN 55022/1998+A1/2000 +A2/2003	Limits and methods of measurement of radio disturbance characteristics of information technology equipment
EN 61000-3-2/2000	Part 3 : Limits-Section 2 : Limits for harmonic current emission (equipment input current <=16A per phase)
EN 61000-3-3/1995 +A1/2001	Part 3 : Limits-Section 3 : Limitation of voltage fluctuations and flicker in low-voltage supply systems for equipment with rated current <=16A
EN 55024/1998 +A1/2001 +A2/2003	Information technology equipment-Immunity characteristics Limits and methods of measurement
	IEC 61000-4-2/2001 Electrostatic discharge immunity test
	IEC 61000-4-3/2002 Radiated, radio-frequency electromagnetic field immunity test
	IEC 61000-4-4/1995 +A1/2000 +A2/2001 Electrical fast transient / burst immunity test
	IEC 61000-4-5/2001 Surge immunity test
	IEC 61000-4-6/2001 Immunity to conducted disturbances, induced by radio-frequency fields
	IEC 61000-4-8/2001 Power Frequency Magnetic field immunity test
	IEC 61000-4-11/2001 Voltage dips, short interruptions and voltage variations immunity test



Leon Liu, Dec. 17 2004
 Leon Liu / Senior Manager

The verification is based on a single evaluation of one sample of above mentioned products. It does not imply an assessment of the whole production and does not permit the use of the test lab. logo.